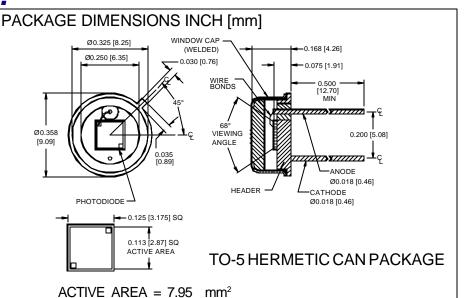
# Silicon Photodiode, U.V. Enhanced Photoconductive DETECTORS INC.

(SFH 291 Industry Equivalent) Type PDU-C119



**PHOTONIC** 



### **FEATURES**

High speed

• U.V. enhanced

U.V window

DESCRIPTION

The **PDU-C119** is a silicon, PIN planar diffused, U.V. enhanced photodiode. Ideal for high speed photoconductive U.V. applications.Packaged in a hermetic TO-5 metal can with a U.V transmitting window cap.

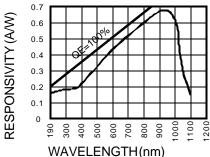
## **APPLICATIONS**

- Spectrometers
- Fluorescent analysers
- U.V. meters
- Colorimeters

# ABSOLUTE MAXIMUM RATING (TA=25°C unless otherwise noted)

SYMBOL	PARAMETER	MIN	MAX	UNITS	
Vbr	Reverse Voltage		30	V	
T <sub>STG</sub>	Storage Temperature	-55	+150	S	
То	Operating Temperature Range	-40	+125	S	
Ts	Soldering Temperature*		+240	с	
Ι	Light Current		500	mA	





\*1/16 inch from case for 3 secs max

### ELECTRO-OPTICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

SYMBOL	CHARACTERISTIC	TESTCONDITIONS	MIN	TYP	MAX	UNITS
lsc	Short Circuit Current	$\rm E_{c}$ = 0.1 mW/cm², $\lambda$ =350 nm	.6	1.0		μA
ΙD	Dark Current	$H = 0, V_{R} = 5 V$		2.5	5	nA
Rsh	Shunt Resistance	$H = 0, V_{R} = 10 \text{ mV}$	150	300		MΩ
TC RSH	RSH Temp. Coefficient	$H = 0, V_{R} = 10 \text{ mV}$		-8		% / °C
CJ	Junction Capacitance	$H = 0, V_R = 0 V^{**}$		130		pF
λrange	Spectral Application Range	Spot Scan	190		1100	nm
R	Responsivity	$V_{R}$ = 0 V, $\lambda$ = 254 nm	.12	.18		A/W
Vbr	Breakdown Voltage	I = 10 µA	15	25		V
NEP	Noise Equivalent Power	V <sub>R</sub> = 10 mV @ Peak		2.2x10 <sup>-14</sup>		W/√ <sup>Hz</sup>
tr	Response Time	$RL = 1 K\Omega V_R = 5 V$		58		nS

Information in this technical data sheet is believed to be correct and reliable. However, no responsibility is assumed for possible inaccuracies or omission. Specifications are subject to change without notice. \*\*f=1 MHz [FORMNO. 100-PDU-C119 REV B]